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Substitute for form 1449A/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet · 1 of 7

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Application Number	10/617,321							
Filing Date	07/10/2003							
First Named Inventor	Choi et al.							
Group Art Unit	2834							
Examiner Name	Dougherty, Thomas M.							
Attorney Docket Number	PA88-30D09							

				U.S. PATENT DOCUMEN	TS	
Examiner Initials*	Cite No.1	U.S. Patent Doct	ument Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Bedevant Passages or Relevant Figures Appear
	B1	4,070,116		Frosch et al.	01-24-1978	
	B2	4,600,309		Fay	07-15-1986	
	B3	4,848,911		Uchida et al.	07-18-1989	
	B4	5,074,667		Miyatake	12-24-1991 /	
	B5	5,148,036		Matsugu et al.	09-15-1992	
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	B7	5,151,754		Ishibashi et al.	09-29-1992	
	B8	5,179,863		Uchida et al.	01-19-1993	
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	B10	5,424,549		Feldman /	06-13-1995	
	B11	5,670,415		Rust	09-23-1997	
	B12	5,743,998		Park/	04-28-1998	
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	B20	6,482,742	B1	Chou	11-19-2002	
	B21	6,534,418	B1	Plat et al.	03-18-2003	
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	B26	5,468,542		Crouch	11-21-1995	
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	B31	5,458,520		DeMercurio et al.	10-17-1995	
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	B33	5,439,766		Day et al.	08-08-1995	
/	B34	5,431,777		Austin et al.	07-11-1995	
Examiner Signature		Thomas )	n. hd		Date Considered	2-3-05

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'Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>6</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

PTO/SB/08A (08-00)

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				Application Number	10/617,321	
INFOR	RMATION	DISC	OSURE	Filing Date	07/10/2003	
STATE	EMENT B	Y APP	LICANT	First Named Inventor	Choi et al.	
				Group Art Unit	2834	
(us	e as many she	ets as nece	ssary)	Examiner Name	Dougherty, Thomas M.	
Sheet	2	of	7	Attorney Docket Number	PA88-30D09	

	<del></del>			U.S. PATENT DOCUMEN	13	<del></del>	
Examiner Initials*	Cite No.1	U.S. Patent Do	Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Peges, Columns, Lines, Whore Relevant Passages or Relevant Figures Appear	
	B35	5,422,295		Choi et al.	06-06-1995		
	B36	5,421,981		Leader et al.	06-06-1995		
	B37	5,417,802		Obeng	05-23-1995		
	B38	5,380,474		Rye et al.	01-10-1995		
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	B40	5,330,881		Sidman et al.	07-19-1894		
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Complete if Known Substitute for form 1449A/PTO **Application Number** 10/617,321 INFORMATION DISCLOSURE 07/10/2003 Filing Date STATEMENT BY APPLICANT First Named Inventor Choi et al. Group Art Unit 2834 (use as many sheets as necessary) Dougherty, Thomas M. Examiner Name Sheet of **Attorney Docket Number** PA88-30D09

	1	U.S. Patent Docu		U.S. PATENT DOCUMENTS	<del></del>	Pages, Columns, Lines,
Examiner Initials*	Cite No.1	Number	Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
	B69	4,999,280		Hiraoka	03-12-1991	
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Complete if Known Substitute for form 1449A/PTO **Application Number** 10/617,321 INFORMATION DISCLOSURE Filing Date 07/10/2003 STATEMENT BY APPLICANT First Named Inventor Choi et al. **Group Art Unit** 2834 (use as many sheets as necessary) Dougherty, Thomas M. **Examiner Name** Sheet Attorney Docket Number PA88-30D09 of

				U.S. PATENT DOCUMENTS	S	
Examiner Inilials*	Cite No. <sup>4</sup>	U.S. Patent Door	iment Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Ratevant Passages or Relevant Figures Appear
	B103	6,646,662	B1	Nebashi et al.	11-11-2003	
	B104	6,677,252	B2	Marsh	01-13-2004	
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STAT	EMENT BY	AP	PLICANT	First Named Inventor	Choi et al.	
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	B114	JP	63-138730		Koji	12-01-1986		
	B115	JP	55-88332		Masahiro	12-26-1978		
	B116	JP	57-7931		Tadao et al.	06-18-180		1
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Substitu	ute for form 1449B/P1	·0		Complete if Known		
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INF	ORMATION I	DIS	CLOSURE	Filing Date	07/10/2003	
STA	TEMENT BY	AF	PPLICANT	First Named Inventor	Choi et al.	
				Group Art Unit	2834	
	(use as many sheet	s as n	ecessary)	Examiner Name	Dougherty, Thomas M.	
Sheet	6	of	7	Attorney Docket Number	PA88-30D09	

OTHER PRIO	R ART - I	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	B119	Abstract of Japanese Patent 63-138730	
	B120	Abstract of Japanese Patent 55-88332	
	B121	Abstract of Japanese Patent 57-7931	
	B122	Abstract of Japanese Patent 02-92603.	
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	B126	HEIDARLet al., "Nanoimprint Lithography at the 6 in. Wafer Scale," Journal of Vacuum Science Technology, Nov/Dec 2000, pp. 3557-3560, vol. B, no. 18(6)/	
	B127	NERAC.COM Retro Search, "Reduction of Dimension of Contact Holes", August 31, 2004	
	B128	NERAC.COM Retro Search, "Trim Etching of Features Formed on an Organic Layer", September 2, 2004	
	B129	NERAC.COM Retro Search, "Multi-Layer Resists", September 2, 2004	

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				Examiner Name	Dougherty, Thomas M.	
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